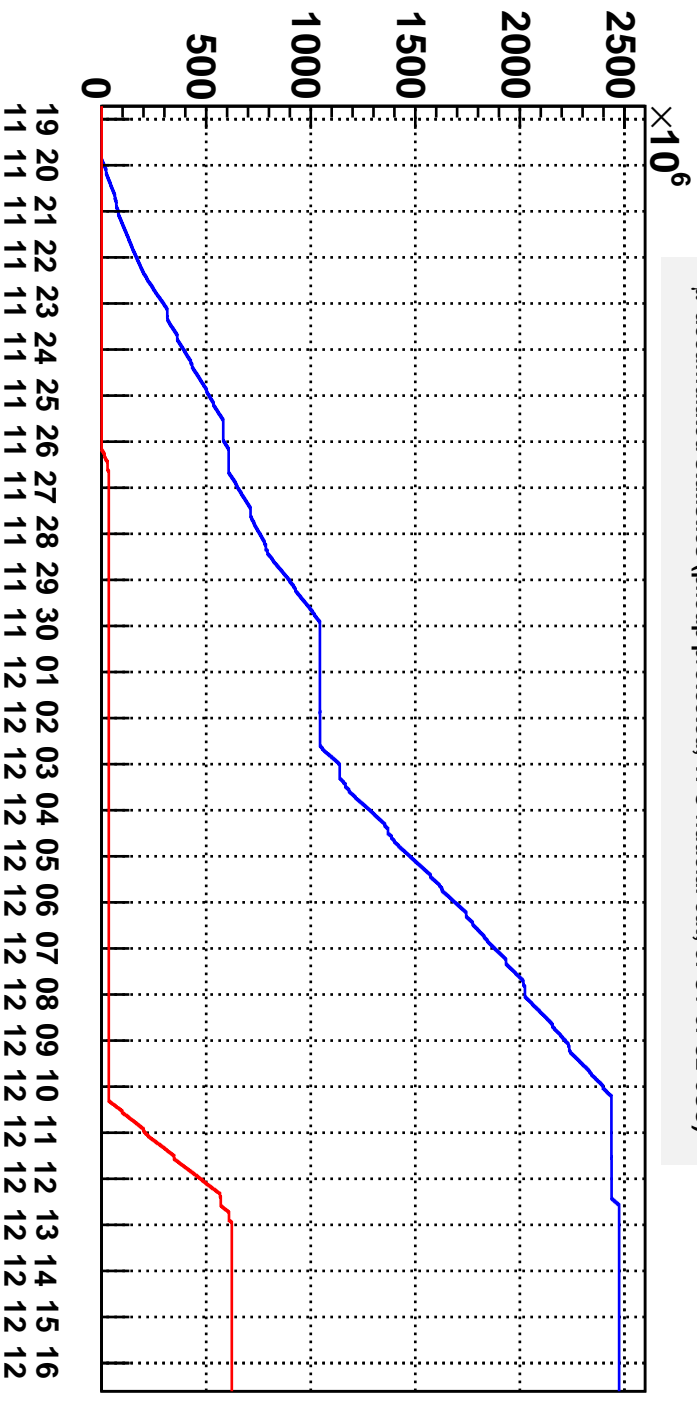


μ^+ accumulated statistics (pileup protected, TPC fiducial cut, ePC1*ePC2*ESC)



pure D2 production

D2+N2

μ^+

N2

MPC

Nal operational

WFD in electronics